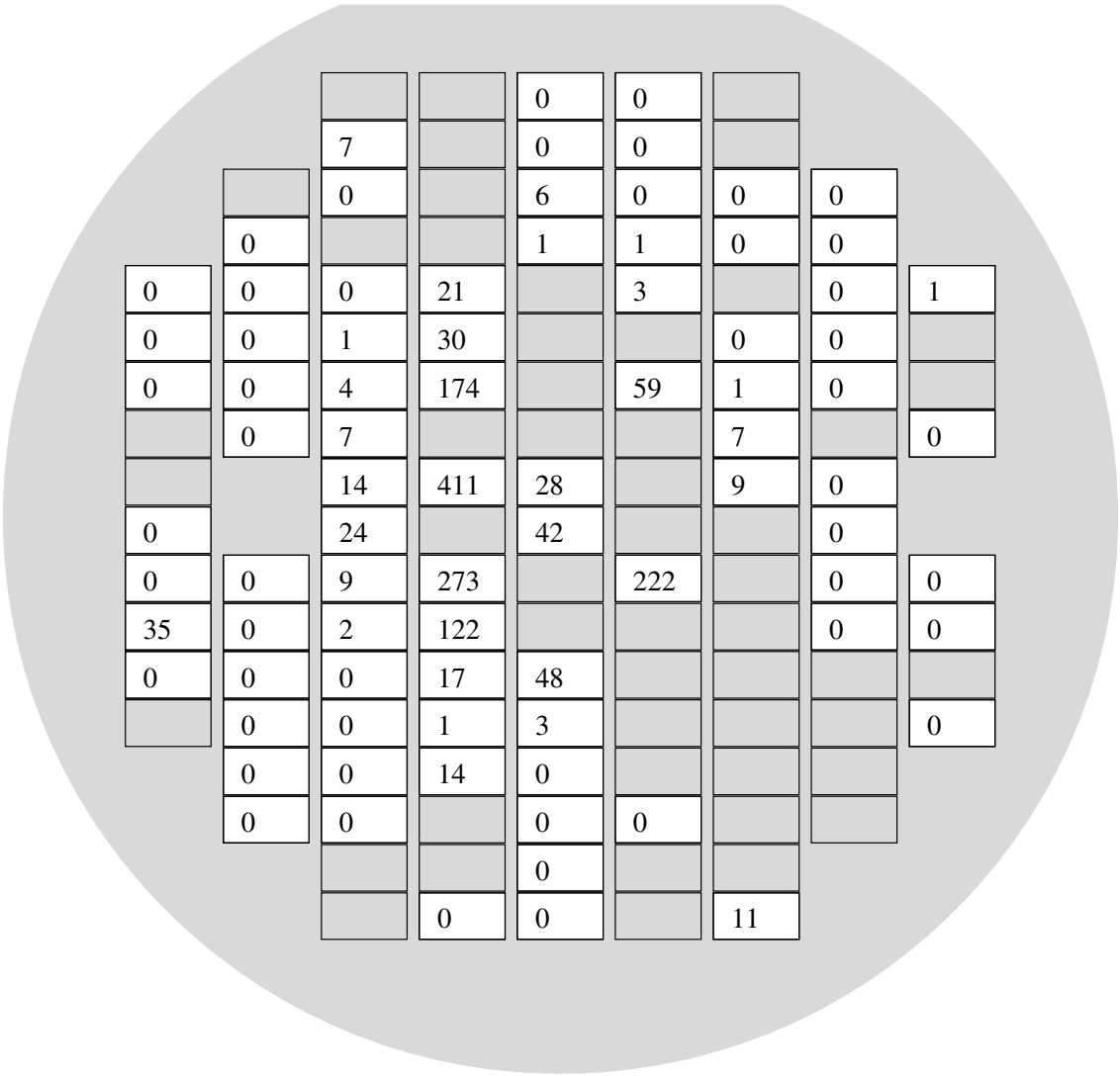
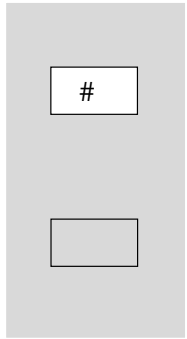
Random bad cell map for wafer 170 s/n: Y21316-12-18

Date: 07/06/99





Number of bad cells in random locations

No info